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ATTENTION: BOX AFTER FINAL
RESPONSE UNDER 37 C.F.R. § 1.116
EXPEDITED PROCEDURE REQUESTED
EXAMINING GROUP 2863

PATENT
Customer No. 22,852
Attorney Docket No. 3180.0269-00

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

Chie IWASA

Application No.: 09/708,490

Filed: November 9, 2000

For: SEMICONDUCTOR TESTING METHOD
AND SEMICONDUCTOR TESTING
APPARATUS FOR SEMICONDUCTOR
DEVICES, AND PROGRAM FOR
EXECUTING SEMICONDUCTOR TESTING
METHOD

Group Art Unit: 2863

Examiner: Lau, Tung S.

Commissioner for Patents
Washington, DC 20231

Sir:

AMENDMENT AFTER FINAL

In reply to the Final Office Action of September 5, 2002, the period for reply having been extended through March 5, 2003 by a Petition for Extension of Time and fee filed herewith, and pursuant to 37 C.F.R. § 1.116, Applicant proposes that this application be amended as follows:

IN THE CLAIMS:

Please amend claims 5, 9, 13, 16, and 19 as follows: